


<b>Search Notes</b>  	<b>Application/Control No.</b>  10570231	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN ET AL.
	<b>Examiner</b>  JASON M NOLAN	<b>Art Unit</b>  1626

### SEARCHED

Class	Subclass	Date	Examiner
514	80, 89, 338, 406	2/14/08	JMN
546	22, 24	2/14/08	JMN
548	113	2/14/08	JMN

### SEARCH NOTES

Search Notes	Date	Examiner
Abstract, Oath, Spec, 371 Docs, US Provisional, reviewed	2/14/08	JMN
EAST Class/Subclass/Keyword Search - attached	2/14/08	JMN
STN Structure Search (Registry/Caplus) - attached	2/14/08	JMN
IDS Considered - attached	2/14/08	JMN
Inventor Search (eDAN) - reviewed for double patenting	2/14/08	JMN

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
514	80, 89, 338, 406	2/14/08	JMN
546	22, 24	2/14/08	JMN
548	113	2/14/08	JMN